IAP15 Rec'd PCT/PTO 02 DEC 2005

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Appl. No.

: 371 of PCT/KR2004/00374

Applicant

: Gyu Chul YI et al.

Filed

: Herewith

TC/A.U.

: Not Yet Assigned

Examiner

: Not Yet Assigned

Docket No.

: 1751-391

Customer No.

: 06449

Confirmation No.

: Not Yet Assigned

INFORMATION DISCLOSURE STATEMENT

Director of the United States Patent and Trademark Office P.O. Box 1450 Alexandria, Virginia 22313-1450

Dear Sir:

Under the provisions of 37 C.F.R. §§ 1.56, 1.97 and 1.98, Applicant submits herewith a copy of the International Search Report and information that the Office may wish to consider in examination of the subject application. Materials submitted for consideration are listed on the attached form PTO-1449.

Respectfully submitted,

Ву

G. Franklin Rothwell Attorney for Applicants Registration No. 18,125

ROTHWELL, FIGG, ERNST & MANBECK, p.c.

Suite 800, 1425 K Street, N.W. Washington, D.C. 20005 Telephone: (202)783-6040

Enclosure(s): International Search Report (5) Cited References

IAP15 Rec'd PCT/PTO 02 DEC 2005

•			Complete if Known 10 / 55889			
			Application Number	371 of PCT/KR2004/000374		
INFORMATION DISCLOSURE STATEMENT BY APPLICANT			Filing Date	Herewith		
			First Named Inventor	Gyu Chul YI et al.		
			Group Art Unit			
			Examiner Name			
			Confirmation No.			
Sheet	1	of	Attorney Docket Number	1751-391		

			U.	S. PATE	IN٦	DOCUMENTS			-	
		U.S. Patent Document				A		Data of Date of		
Examiner Initials*	Cite No. ¹	Number Ki		Kind Code ² (if known)		Name of Patentee or Applicant of Cited Document		Date of Publication of Cited Document MM-DD-YYYY		nt
			FOR	EIGN PA	\TE	ENT DOCUMEN	ітѕ			
		Foreign Patent Document					3,510		ata af Dabliantian	
Examiner Initials*	Cite No.1	Office ³ Code	Number⁴	Kind ⁵ (if known)			ntee or Applicant of Document		ate of Publication f Cited Document MM-DD-YYYY	T6
	1	JP	2000-031462	Α		CANON INC		01	-28-2000	AE
	2 JP 2003-045661 A 3 JP 2003-073859 A		2003-045661	Α		FUJI PHOTO FIL CO LTD		02-14-2003		AB
			NATIONAL INSTITUTE FOR MATERIALS SCIENCE		03-12-2003		AB			
	4	KR	10-2003-0085272	85272 A POSTECH FOUNDATION		DUNDATION	11-05-2003		AE	
	5	wo	94/00885	A1		ISIS INNOVATION LTD.		01-06-1994		
-										
Examiner Signature			,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,				Date Considered			

^{*}EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

¹Unique citation designation number. ²See attached Kinds of U.S. Patent Documents. ³Enter Office that issued the document, by the two-letter code. ⁴For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. ⁵Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST. 16 if possible. ⁶Applicant is to place a check mark here if English language translation is attached. AB indicates that only an English language abstract is attached.